

WSP4807

Dual P-Ch MOSFET

General Description

The WSP4807 is the highest performance trench P-ch MOSFET with extreme high cell density , which provide excellent R_{DSON} and gate charge for most of the synchronous buck converter applications .

The WSP4807 meet the RoHS and Green Product requirement with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- Green Device Available

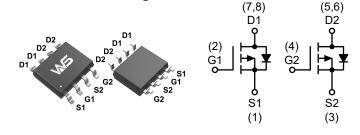
Product Summery

BV _{DSS}	R _{DSON}	I _D
-30V	33mΩ	-6.5A

Applications

 Power Management in Notebook Computer, Portable Equipment and Battery Powered Systems.

SOP-8L Pin Configuration



Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	-30	V
V _{GS}	Gate-Source Voltage	±20	V
I₀@T₀=25℃	Continuous Drain Current, -V _{GS} @ -10V ¹	-6.5	А
I _D @T _C =100℃	Continuous Drain Current, -V _{GS} @ -10V ¹	-5.3	А
I _{DM}	Pulsed Drain Current ²	-20	A
P₀@Tc=25℃	Total Power Dissipation ³	1.5	W
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range -55 to 150		°C

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
R _{θJA}	Thermal Resistance Junction-Ambient ¹	Thermal Resistance Junction-Ambient ¹		
R _{θJC}	Thermal Resistance Junction-Case ¹		36	°C/W

Absolute Maximum Ratings



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Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0V , I _D =-250uA	-30			V
$\triangle BV_{DSS} / \triangle T_J$	BV _{DSS} Temperature Coefficient	Reference to 25 $^\circ\!\mathrm{C}$, I_D=-1mA		-0.02		V/℃
Р	Static Drain-Source On-Resistance ²	V _{GS} =-10V , I _D =-3A	33 46		46	
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =-4.5V , I _D =-1.5A		53	72	mΩ
V _{GS(th)}	Gate Threshold Voltage		-1.0	-1.6	-2.5	V
$ riangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS} = V_{DS}$, ID =-2500A		4		mV/℃
	Drain Source Leekage Current	$V_{\text{DS}}\text{=-24V}$, $V_{\text{GS}}\text{=}0\text{V}$, $T_{\text{J}}\text{=}25^\circ\!\mathrm{C}$			-1	– uA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =-24V , V _{GS} =0V , T _J =70℃			-5	
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm20V$, V_{DS} = $0V$			±100	nA
gfs	orward Transconductance	V _{DS} =-5V , I _D =-3A		5		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		24	48	Ω
Qg	Total Gate Charge (-4.5V)			6.2		
Q _{gs}	Gate-Source Charge	V_{DS} =-20V , V_{GS} =-4.5V , I_{D} =-5A		2.5		nC
Q _{gd}	Gate-Drain Charge			3.3		
T _{d(on)}	Turn-On Delay Time			9.2		
Tr	Rise Time	V_{DD} =-15V , V_{GS} =-10V , R_G =3.3 Ω		16.5		
T _{d(off)}	Turn-Off Delay Time	I _D =-1A		21.3		ns
T _f	Fall Time			21.5		
Ciss	Input Capacitance			640		
C _{oss}	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		270		pF
C _{rss}	Reverse Transfer Capacitance			103		

Diode Characteristics

Symbol	Parameter Conditions		Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,4}	V _G =V _D =0V , Force Current			-6.5	Α
I _{SM}	Pulsed Source Current ^{2,4}				-12	А
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25℃			-1.2	V

Note :

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper,t<10 sec.

2.The data tested by pulsed , pulse width $\,\leq\,$ 300us , duty cycle $\,\leq\,$ 2%

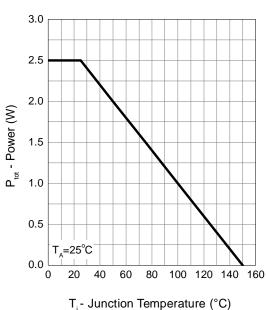
3.The power dissipation is limited by 150 $^\circ\!{\rm C}$ junction temperature

4. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



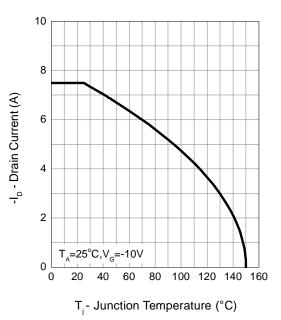
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Typical Operating Characteristics

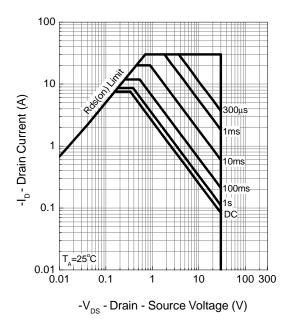


Power Dissipation

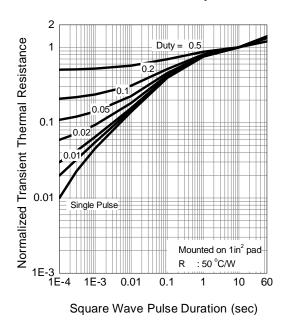




Safe Operation Area

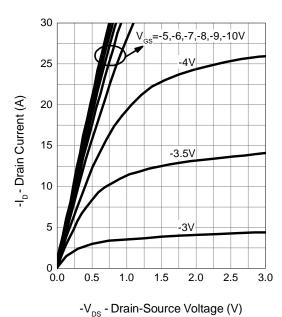


Thermal Transient Impedance



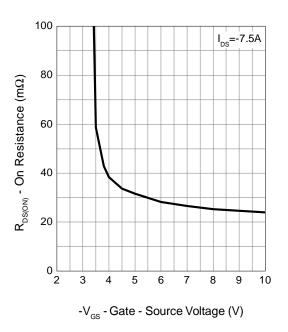


Typical Operating Characteristics (Cont.)

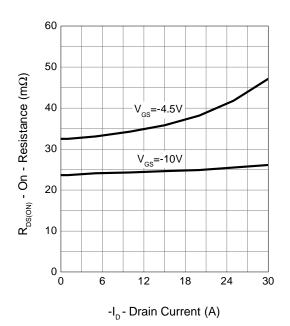


Output Characteristics

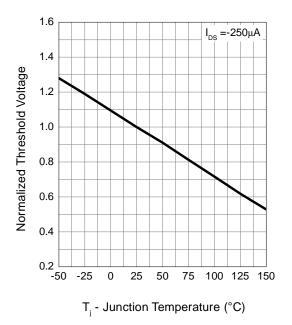
Gate-Source On Resistance



Drain-Source On Resistance

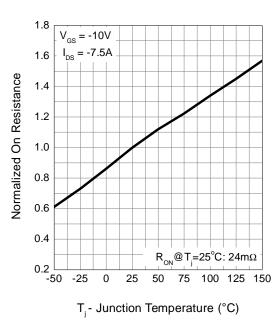


Gate Threshold Voltage



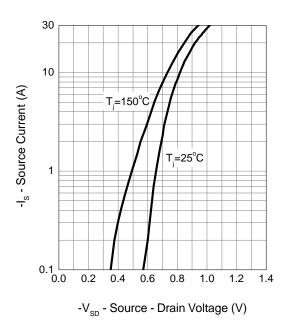


Typical Operating Characteristics (Cont.)

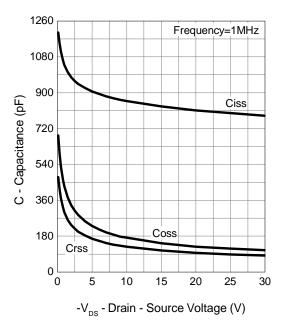


Drain-Source On Resistance

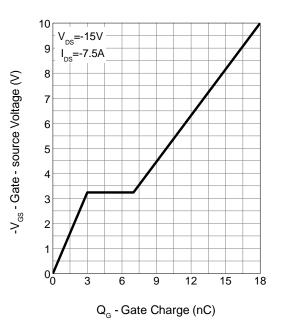
Source-Drain Diode Forward



Capacitance



Gate Charge

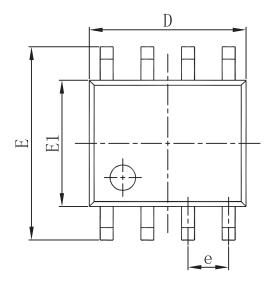


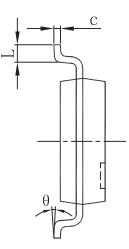


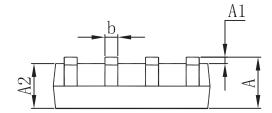
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Packaging information







Grand al	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
А	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
с	0.170	0.250	0.007	0.010	
D	4.800	5.000	0.189	0. 197	
e	1.270 (BSC)		0.050	(BSC)	
Е	5.800	6. 200	0.228	0.244	
E1	3.800	4.000	0.150	0.157	
L	0.400	1.270	0.016	0.050	
θ	0°	8°	0 °	8°	



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